Geometry optimization of polymers via ONIOM based elongation method

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Elongation (ELG): reduced-scaling quantum chemical method for simulation of polymers



Direction of elongation of chain



Polymer chain: monomer residues are included to and excluded from the **active** region to keep its constant size Excluded fragments become **frozen**



Approaches to improvement of ELG

ELG calculation with electrostatic embedding



Atomic charges \leftarrow CSA: CSA – Charge Sensitivity Analysis approximate parametrical method aimed to reproduce quantum chemical level atomic charges.

ELG calculation with mechanical embedding based on ONIOM method

ONIOM Step 1: whole system is calculated on low level of theory Low-level region High-level region Step 2: high-level region is recalculated on high level of theory Active region Following fragments Frozen region ONIOM equation for electronic energy: $E_{ONIOM} = E_{real,low} + E_{model,high} - E_{model,low}$ 2

Step 1

Step 2

Step 2



ELG-IMEE





Computational details: High-level region HF/6-31G Low-level region PM7 3



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Results of geometry optimization

$$\text{RMSD} = \sqrt{\frac{1}{N_{at}} \left(\sum_{i=1}^{N_{at}} \left(r_i^{ELG} - r_i^{ref} \right)^2 \right)}$$

EE = Electrostatic Embedding

Linear polyethylene chain

- testing system (almost optimized)
- non-polar

Distorted polyethylene chain

- randomly distorted
- non-polar





Nylon-6

- randomly distorted
- chain is slightly polarized





Future plans

